

INTERNATIONAL STANDARD

NORME INTERNATIONALE

**Solderless connections –
Part 4: Non-accessible insulation displacement (ID) connections –
General requirements, test methods and practical guidance**

**Connexions sans soudure –
Partie 4: Connexions autodénudantes (CAD) non accessibles –
Règles générales, méthodes d'essai et guide pratique**



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INTERNATIONAL ELECTROTECHNICAL COMMISSION

SOLDERLESS CONNECTIONS –**Part 4: Non-accessible insulation displacement (ID) connections –
General requirements, test methods and practical guidance**

FOREWORD

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International Standard IEC 60352-4 has been prepared by subcommittee 48B: Electrical connectors, of IEC technical committee 48: Electrical connectors and mechanical structures for electrical and electronic equipment.

This second edition cancels and replaces the first edition, published in 1994, and its Amendment 1 (2000). This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) Transferred Clauses 9 to 13 into Annex A (informative).
- b) The figures were re-drawn for clarity.

The text of this International Standard is based on the following documents:

FDIS	Report on voting
48B/2804/FDIS	48B/2820/RVD

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 60352 series, published under the general title *Solderless connections*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

INTRODUCTION

The two following parts of IEC 60352 are available on solderless insulation displacement connections:

- Part 3: Accessible insulation displacement (ID) connections – General requirements, test methods and practical guidance;
- Part 4: Non-accessible insulation displacement (ID) connections – General requirements, test methods and practical guidance.

NOTE In this document the term "insulation displacement" is abbreviated to "ID", for example "ID connection", "ID termination".

Figure 1 illustrates examples of accessible and non-accessible insulation displacement connections that clarify the difference among them.

Part 4 includes requirements and relevant tests (normative) as well as a practical guidance in Annex A (informative) for non-accessible ID connections.

Two test schedules are provided:

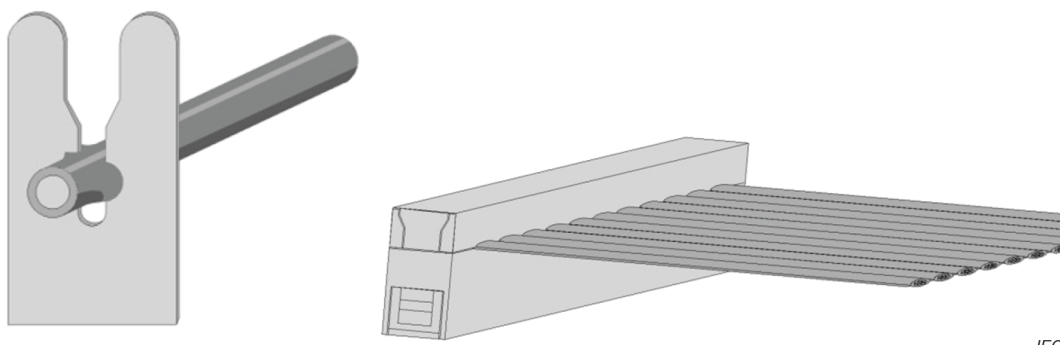
- the basic test schedule which applies to insulation displacement connections which conform to all prerequisites of Clause 5. It is derived from experience with successful applications of such connections;
- the full test schedule which applies to insulation displacement connections which do not fully conform to all prerequisites of Clause 5, for example which are manufactured using materials or finishes not included in Clause 5.

This philosophy permits cost and time effective performance verification using a limited basic test schedule for established insulation displacement connections and an expanded full test schedule for connections requiring more extensive performance validation.

The suitability of the non-accessible ID connection implies that the specified requirements and tests apply to all factors involved in producing a suitable ID connection, namely:

- the ID termination, which may be part of a single-pole or multipole connector;
- the wire (or range of wires) for which the termination is suitable;
- the tools (if any) required to produce that type of solderless connection.

The practical guidance provided in Annex A (informative) serves as a guideline for the required workmanship. Attention is drawn to the fact that some industries (e.g. automotive, aerospace, nuclear, military) may have specific workmanship standards and/or quality requirements, which are outside the scope of this document.



IEC

Figure 1 – Example of accessible and non-accessible insulation displacement connection

IEC Guide 109 advocates the need to minimise the impact of a product on the natural environment throughout the product life cycle.

It is understood that some of the materials permitted in this document can have a negative environmental impact.

As technological advances lead to acceptable alternatives for these materials, they will be eliminated from the document.

SOLDERLESS CONNECTIONS –

Part 4: Non-accessible insulation displacement (ID) connections – General requirements, test methods and practical guidance

1 Scope

This part of IEC 60352 is applicable to non-accessible ID connections for which the tests and measurements according to Clauses 6 through 8 are suitable and which are made with:

- appropriately designed ID terminations;
- wires having solid round conductors of 0,25 mm to 3,6 mm nominal diameter;
- wires having stranded conductors of 0,05 mm² to 10 mm² cross-sectional area;

for use in electrical and electronic equipment and components.

Information on materials and data from industrial experience is included in addition to the test procedures to provide electrically stable connections under prescribed environmental conditions.

There are different designs and materials for ID terminations in use. For this reason, only fundamental parameters of the termination are specified, while the performance requirements of the wire and the complete connection are specified in full detail.

The purpose of this document is:

- to determine the suitability of non-accessible ID connections under specified mechanical, electrical and atmospheric conditions;
- to provide a means of comparing test results when the tools used to make the connections, if any, are of different designs or manufacture.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050-581, *International Electrotechnical Vocabulary – Part 581: Electromechanical components for electronic equipment*

IEC 60068-1, *Environmental testing – Part 1: General and guidance*

IEC 60228, *Conductors of insulated cables*

IEC 60512-1, *Connectors for electrical and electronic equipment – Tests and measurements – Part 1: Generic specification*

IEC 60512-1-1, *Connectors for electronic equipment – Tests and measurements – Part 1-1: General examination – Test 1a: Visual examination*